Characterization of the Hamamatsu R11265 multi-anode photomultiplier tube with single photon signals

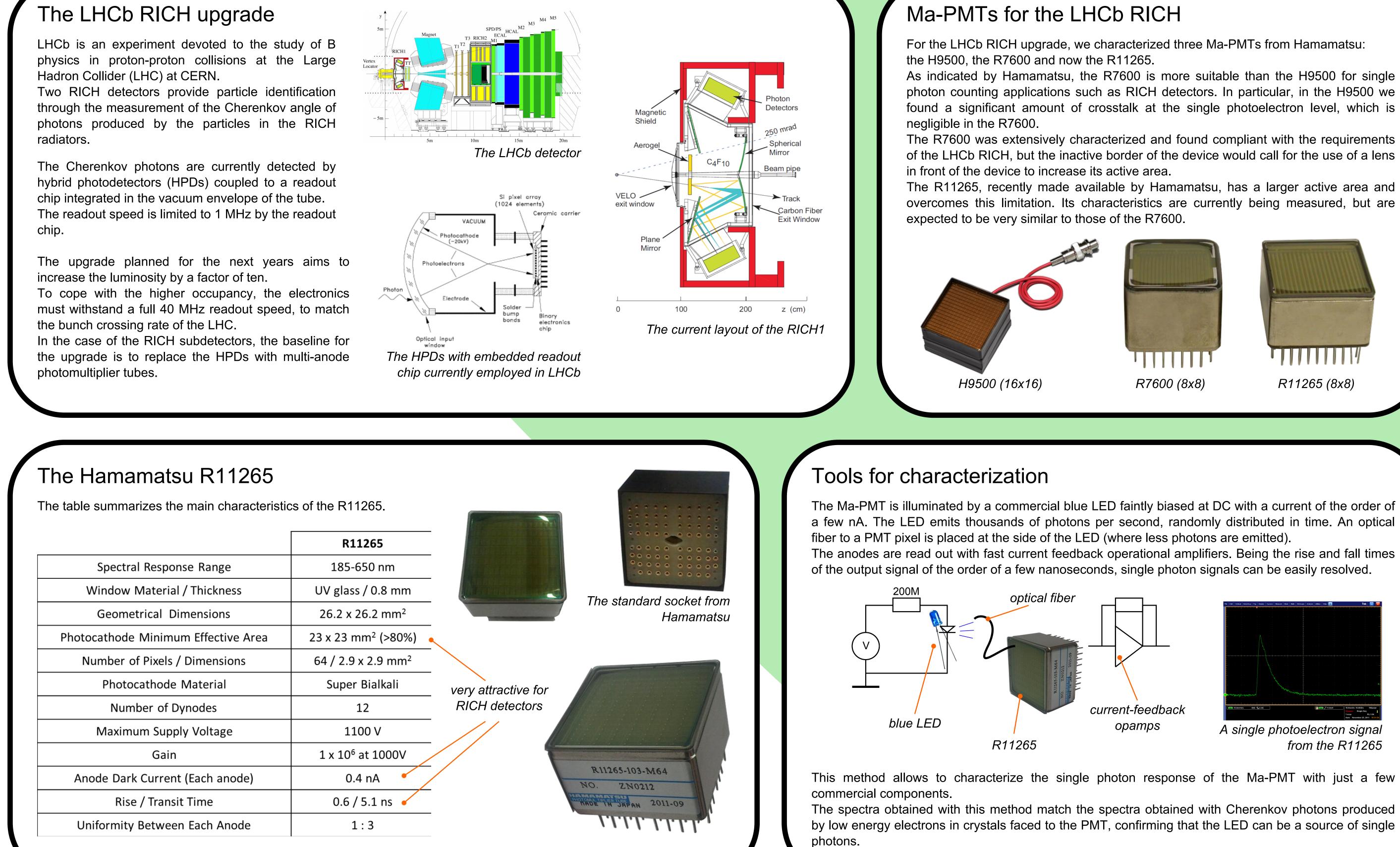
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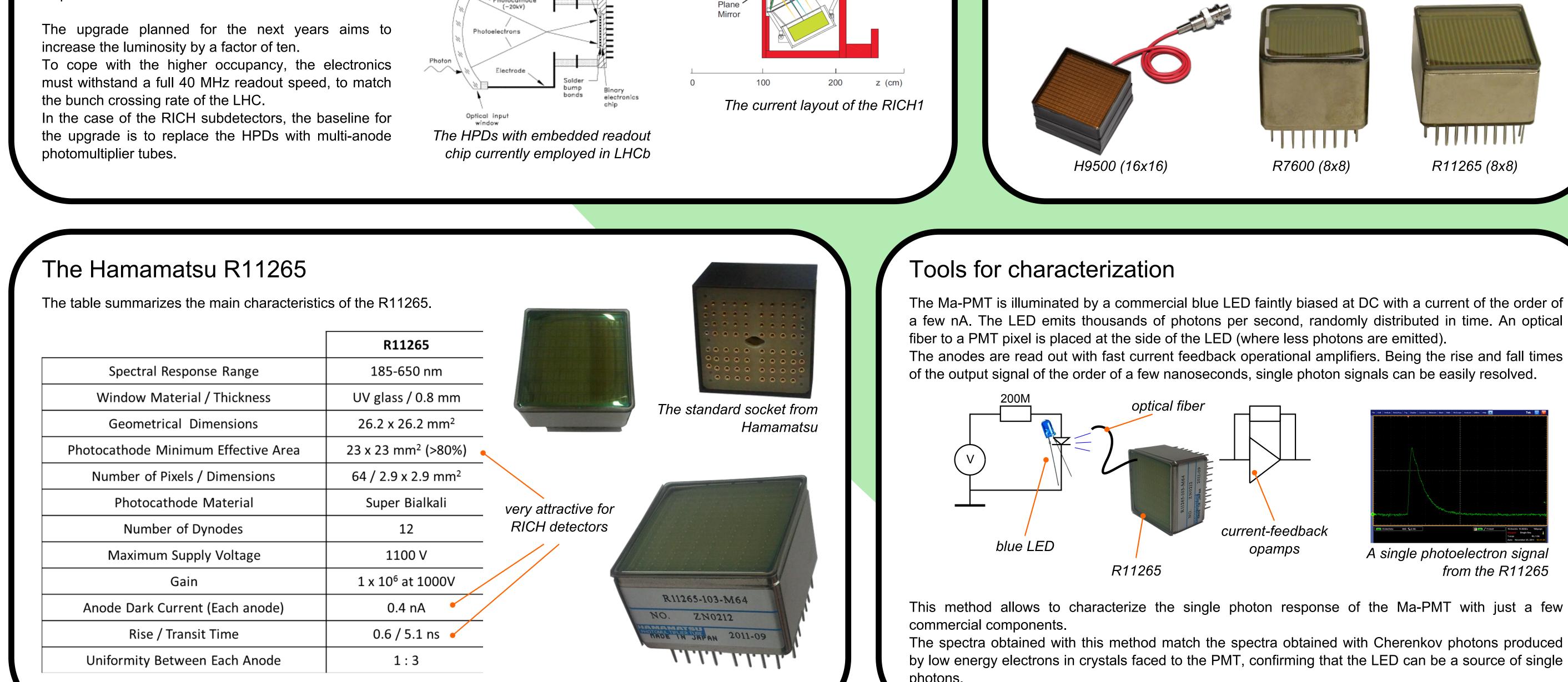
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radiators.

chip integrated in the vacuum envelope of the tube.



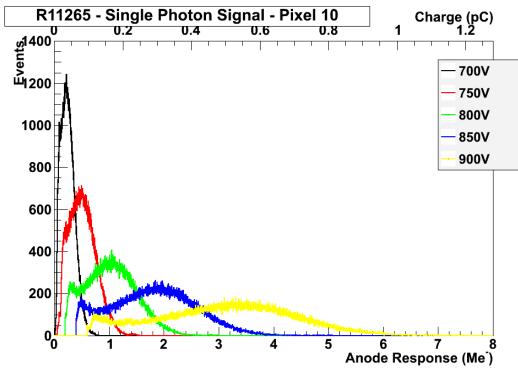


Gain and uniformity

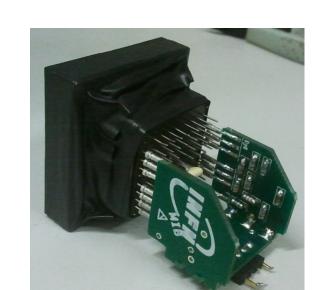
The single photolectron gain of the device was measured with the standard HV bias ratio from Hamamatsu. The mean signal for pixel 10 is about 1.9 Me⁻ at 850 V.

Voltage Distribution Ratio and Supply Voltage

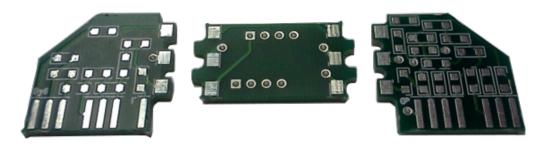
Electrodes	K		Dy	y1	Dy	/2	Dy3	Dy	4	Dy5	Dy6	D	y7	Dy	y8	Dy9	Dy	10	Dy11	Dy	12	G .]	R	Р
Ratio		2.	3	1.	2	1		1	1	1	l	1	1		1		1	1		1	1		0.5	
Supply Voltage : 1000 V				K : Cathode				Dy : Dynode			G.R : Guard Ring				P :	Anod	e							



Single photon spectra at different HV values



The R11265 equipped with the custom bias PCBs



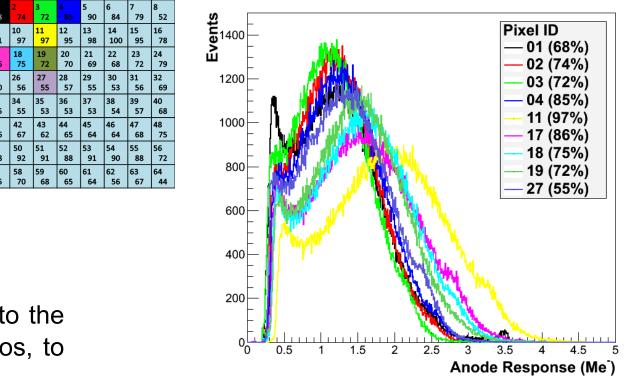
Custom PCBs for HV bias were designed, as an alternative to the Hamamatsu socket. This will allow to test other HV bias ratios, to find the optimal values for our application.

Moreover, in this way the capacitance between anodes can be minimized (good to eliminate crosstalk in the readout electronics).

The gain uniformity of the device was measured at the single photoelectron level, and found compiant with the Hamamatsu specifications, which are given for continuous light.

The mamimum gain spread between pixels is 2.3, a very good figure.

R11265 - Single Photon Signal at -850V



Gain uniformity between pixels

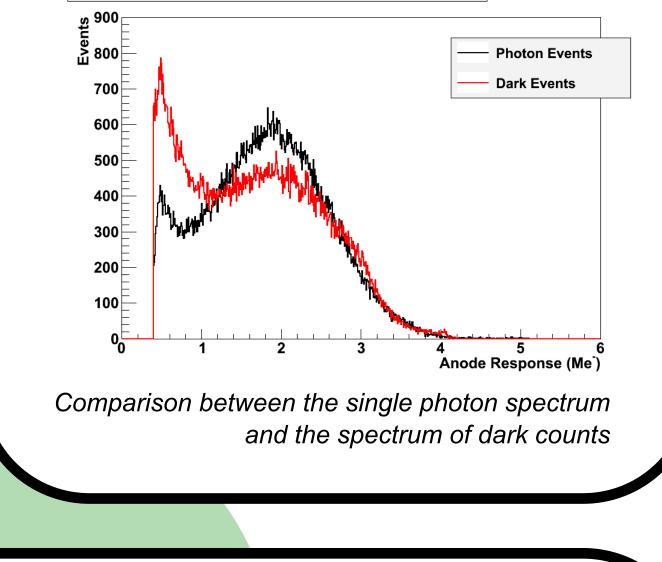
Dark counts

The dark current was evaluated by counting events above threshold (200 ke⁻ at 850 V), to simulate false counts in the RICH. Groups of four pixels were put in parallel, and the following rates were observed:

-Pixels 1+2+3+4: rate of 5.2 Hz (65 hours) -Pixels 9+10+11+12: rate of 4.5 Hz (44 hours) -Pixels 17+18+19+20: rate of 3.7 Hz (41 hours)

The average dark count rate per pixel is about 1 Hz.

R11265 - Single Photon Signal vs Dark Events - Pixel 10



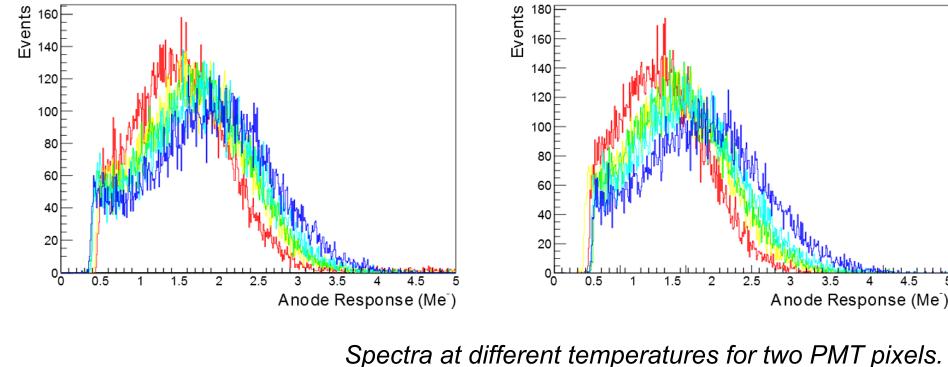
Gain vs temperature

The single photon response of the PMT was tested at different temperatures in a Votsch 4018 environmental chamber, from -30° to 50°.

The measurements show a gain decrease with increasing temperature. The gain is roughly proportional to 1/T (where T is the absolute temperature).

The measurements will be completed with a measurement of the variation of dark

count rate, which is expected to increase at higher temperatures.



(blue: -30°, to red, 50°, in steps of 20°)

devices. The gain decrease is expected to be proportional to the axial component of magnetic field with respect to the PMT. The other components are expected to cause negligible effects. The maximum gain decrease is expected in the pixels at the border of the PMT.

The devices in the RICH must operate in the presence of the

residual magnetic field from the LHCb magnet, up to 30 G for

It is known that magnetic field causes gain decrease in such

Plans for tests in a magnetic field

the RICH1, less for the RICH2.

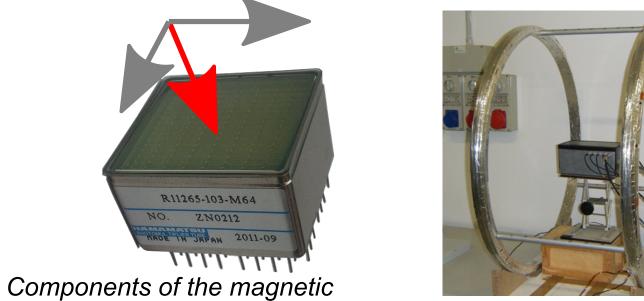
R11265-103-M64

THE IN JAPAN 2011-09

shown in red

NO. ZN0212

field: the axial component is



The Helmholtz coil that will be used for characterization

Future characterization

The study of the device will proceed with:

- measurement of dark count rate vs temperature
- characterization in magnetic field
- crosstalk measurement
- investigation on the optimal bias voltage ratio - aging of the device

In particular, aging may be a delicate issue for the LHCb RICH. The current estimates for event rates in the hottest regions of the RICH detectors can reach 10 MHz per pixel: in these conditions, a noticeable aging is expected in a few months of operation. This may indicate the need to operate the devices with the lowest possible bias voltage, to mitigate the aging effects.

PhotoDet 2012 - International Workshop on New Photon-Detectors

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